

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10622294	CHOWN, DAVID
	Examiner	Art Unit
	Liu, Li	2613

SEARCHED

Class	Subclass	Date	Examiner
372	102	08/03/2006	LL
398	41-43, 152, 129, 58, 122, 125	08/03/2006, 02/08/2007	LL
385	12, 24, 93, 49	08/03/2006, 02/08/2007	LL
250	25	08/03/2006	LL

SEARCH NOTES

Search Notes	Date	Examiner
EAST		
USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	08/03/2006, 02/08/2007	LL
Google	08/03/2006	LL
IEEE	08/03/2006	LL

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner